

**Search Notes**

Application/Control No.

10/630,435

Examiner

Kien T. Nguyen

Applicant(s)/Patent under  
Reexamination

KRULL, MARK A.

Art Unit

3714

**SEARCHED**

Class	Subclass	Date	Examiner
446	1 71 491	7/24/2005	KN
472	137	7/24/2005	KN
446	227	11/16/05	KN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR